

Notice of References Cited

Application/Control No.

10/593,633

Applicant(s)/Patent Under
Reexamination
YAMANE ET AL.

Examiner

James W. Taylor, II

Art Unit

4171

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 2001261954 A	09-2001	Japan	YAMANE et al.	
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NON-PATENT DOCUMENTS

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